

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/690,114	SINISI, JOHN P.	
Examiner		Art Unit		Page 1 of 1
Cong-Lac Huynh		2178		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0052861 A1	12-2001	Ohmura et al.	340/988
*	B	US-2002/0038076 A1	03-2002	Sheehan et al.	600/200
*	C	US-2002/0093493 A1	07-2002	Michaeli et al.	345/173
*	D	US-2002/0188522 A1	12-2002	McCall et al.	705/26
*	E	US-2003/0023443 A1	01-2003	Shizuka et al.	704/260
*	F	US-2004/0098269 A1	05-2004	Wise et al.	705/001
*	G	US-2004/0193824 A1	09-2004	Johnson, Steven C.	711/170
*	H	US-2006/0171683 A1	08-2006	Battaglia et al.	386/107
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Lieberman, Out of Many, One: Reliable Results from Unreliable Recognition, ACM 2002, pages 728-729.
	V	Cross et al., Layered Annotations of Digital Images for Data Collection in the Field, IEEE 2003, pages 1-6.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.